## Notic of References Cited

Application/Control No. 09/667,775	Reexaminati	Applicant(s)/Patent Under Reexamination KAWANISHI ET AL.	
Examiner	Art Unit		
Johannes P Mondt	2826	Page 1 of 1	

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Ä	US-5,976,175	11-1999	Hirano et al.	607-89
	В	·US-			
	С	US-			
	D	US-			
	Ε	US-			
	F	US-			
	G	US-			
	Н	US-			
	_	US-			
	7	US-			
	к	US-			
	L	US-	-		
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP407072311A	03-1995	Japan	Nishino, J. et al	G02B003/06
	0					
	Р					
	Q				·	
	R					
	s					
	Т					

NON-PATENT DOCUMENTS				
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)		
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	w			
	х			

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.